



YEA SHIN TECHNOLOGY CO., LTD

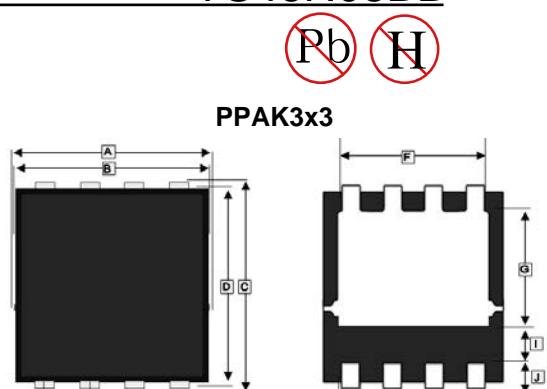
YS46N03BB

N-Channel Enhancement MOSFET

VDS= 30V, ID = 46A

DESCRIPTION

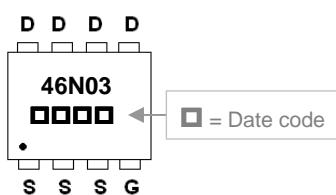
The YS46N03BB provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness. The PAK3x3 package is universally preferred for all commercial-industrial surface mount applications and suited for low voltage applications such as DC/DC converters.



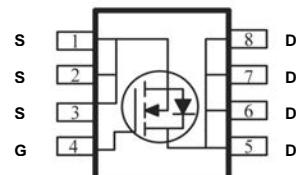
FEATURES

- Lower Gate Charge
- Simple Drive Requirement
- Fast Switching Characteristic

MARKING



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	3.20	3.40	G	1.55	1.98
B	2.90	3.20	H	0.24	0.35
C	3.05	3.45	I	0.35	TYP.
D	2.90	3.20	J	0.60	TYP.
E	0.65	BSC.	K	0.10	0.25
F	2.15	2.59	L	0.70	0.90



PACKAGE INFORMATION

Package	MPQ	Leader Size
PPAK3x3	3K	13 inch

ABSOLUTE MAXIMUM RATINGS ($T_A=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	30	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current ¹ @ $V_{GS}=10\text{V}$	I_D	46	A
		29	
		11	
		8.7	
Pulsed Drain Current ²	I_{DM}	92	A
Single Pulse Avalanche Energy ³	E_{AS}	130	mJ
Avalanche Current	I_{AS}	34	A
Power Dissipation ⁴	P_D	29	W
Operating Junction & Storage Temperature	T_J, T_{STG}	55~150	°C
Thermal Resistance Rating			
Thermal Resistance Junction-Ambient ¹ (Max).	$R_{\theta JA}$	75	°C / W
Thermal Resistance Junction-Case ¹ (Max).	$R_{\theta JC}$	4.31	°C / W

YS46N03BB

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static						
Drain-Source Breakdown Voltage	BV_{DSS}	30	-	-	V	$\text{V}_{\text{GS}}=0, \text{I}_D=250\mu\text{A}$
Gate-Threshold Voltage	$\text{V}_{\text{GS(th)}}$	1	-	2.5	V	$\text{V}_{\text{DS}}=\text{V}_{\text{GS}}, \text{I}_D=250\mu\text{A}$
Gate-Source Leakage Current	I_{GSS}	-	-	± 100	nA	$\text{V}_{\text{GS}}= \pm 20\text{V}$
Drain-Source Leakage Current	I_{DSS}	-	-	1	μA	$\text{V}_{\text{DS}}=24\text{V}, \text{V}_{\text{GS}}=0, T_J=25^\circ\text{C}$
		-	-	5		$\text{V}_{\text{DS}}=24\text{V}, \text{V}_{\text{GS}}=0, T_J=55^\circ\text{C}$
Static Drain-Source On-Resistance ²	$\text{R}_{\text{DS(ON)}}$	-	-	9	$\text{m}\Omega$	$\text{V}_{\text{GS}}=10\text{V}, \text{I}_D=30\text{A}$
		-	-	13.5		$\text{V}_{\text{GS}}=4.5\text{V}, \text{I}_D=15\text{A}$
Gate Resistance	R_g	-	2.1	3.5	Ω	$f = 1.0\text{MHz}$
Total Gate Charge(10V)	Q_g	-	10.6	-	nC	$\text{I}_D=15\text{A}$ $\text{V}_{\text{DS}}=15\text{V}$ $\text{V}_{\text{GS}}=4.5\text{V}$
Gate-Source Charge	Q_{gs}	-	4.2	-		
Gate-Drain Change	Q_{gd}	-	4	-		
Turn-on Delay Time ²	$\text{T}_{\text{d(on)}}$	-	6.4	-	nS	$\text{V}_{\text{DD}}=15\text{V}$ $\text{I}_D=15\text{A}$ $\text{V}_{\text{GS}}=10\text{V}$ $\text{R}_G=3.3\Omega$
Rise Time	T_r	-	70.6	-		
Turn-off Delay Time	$\text{T}_{\text{d(off)}}$	-	22.4	-		
Fall Time	T_f	-	8	-		
Input Capacitance	C_{iss}	-	1127	-	pF	$\text{V}_{\text{GS}}=0$ $\text{V}_{\text{DS}}=15\text{V}$ $f = 1.0\text{MHz}$
Output Capacitance	C_{oss}	-	194	-		
Reverse Transfer Capacitance	C_{rss}	-	77	-		
Guaranteed Avalanche Characteristics						
Single Pulse Avalanche Energy ³	EAS	45	-	-	mJ	$\text{V}_D=25\text{V}, L=0.1\text{mH}, I_{AS}=20\text{A}$
Source-Drain Diode						
Diode Forward Voltage ²	V_{SD}	-	-	1	V	$\text{I}_S=1\text{A}, \text{V}_{\text{GS}}=0, T_J=25^\circ\text{C}$
Continuous Source Current ^{1,4}	I_S	-	-	46	A	$\text{V}_D=\text{V}_G=0$, Force Current
Pulsed Source Current ^{2,4}	I_{SM}	-	-	92	A	
Reverse Recovery Time	T_{rr}	-	12	-	nS	$\text{I}_F=30\text{A}, dI/dt=100\text{A}/\mu\text{s}$, $T_J=25^\circ\text{C}$
Reverse Recovery Charge	Q_{rr}	-	3.7	-	nC	

Note:

1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper , $\leq 10\text{sec}$, $125^\circ\text{C}/\text{W}$ at steady state
2. The data tested by pulsed , pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$
3. The EAS data shows Max. rating . The test condition is $\text{V}_{\text{DD}}=25\text{V}, \text{V}_{\text{GS}}=10\text{V}, \text{L}=0.1\text{mH}, \text{I}_{\text{AS}}=34\text{A}$
4. The power dissipation is limited by 150°C junction temperature
5. The Min. value is 100% EAS tested guarantee.
6. The data is theoretically the same as ID and IDM , in real applications , should be limited by total power dissipation.

YS46N03BB

CHARACTERISTIC CURVES

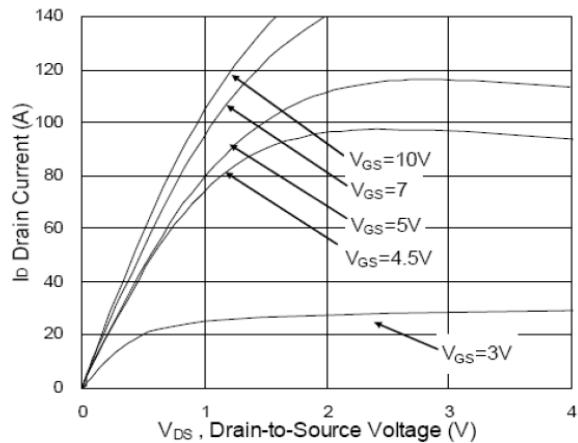


Fig.1 Typical Output Characteristics

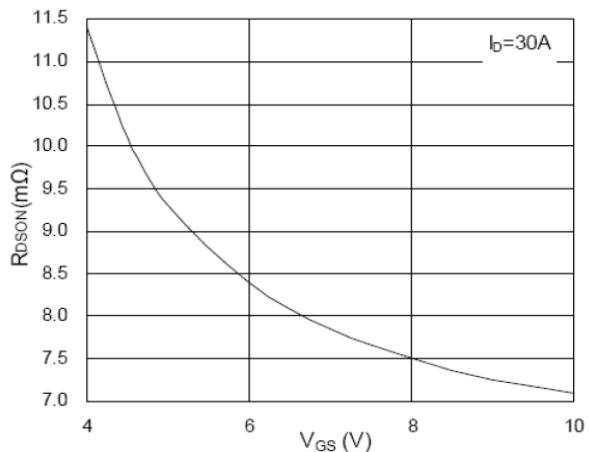


Fig.2 On-Resistance vs. Gate-Source

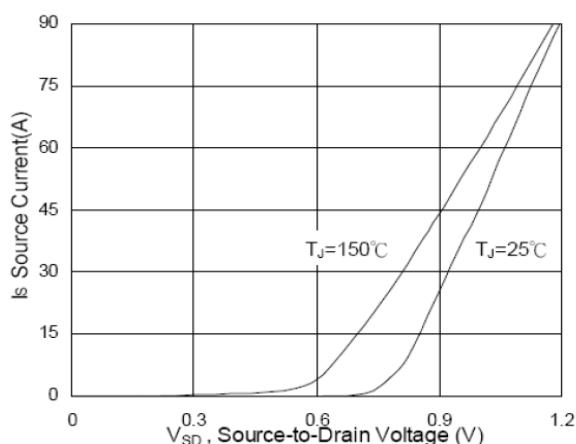


Fig.3 Forward Characteristics of Reverse

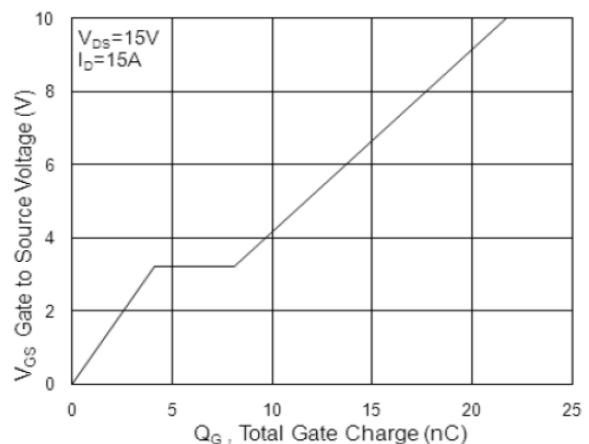


Fig.4 Gate-Charge Characteristics

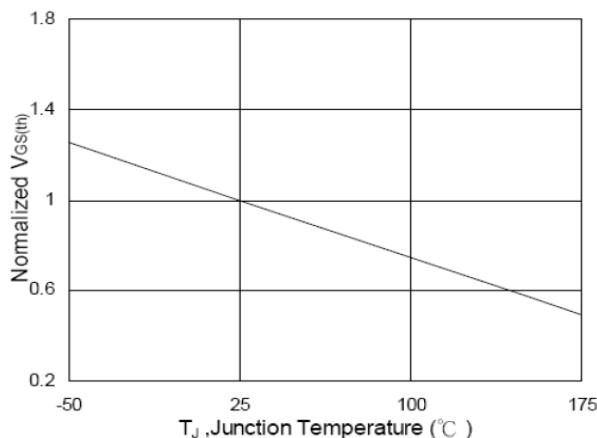


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

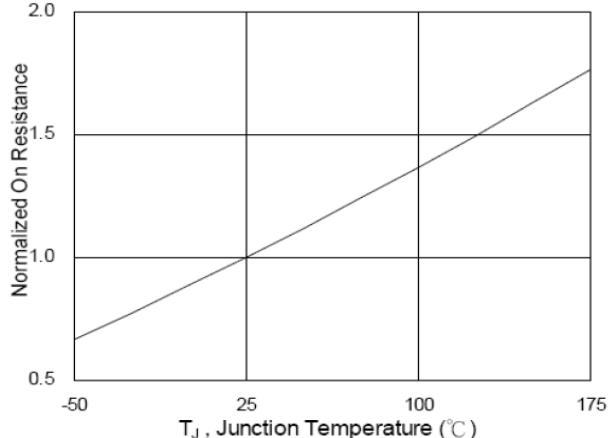


Fig.6 Normalized $R_{DS(on)}$ vs. T_J

YS46N03BB

CHARACTERISTIC CURVES

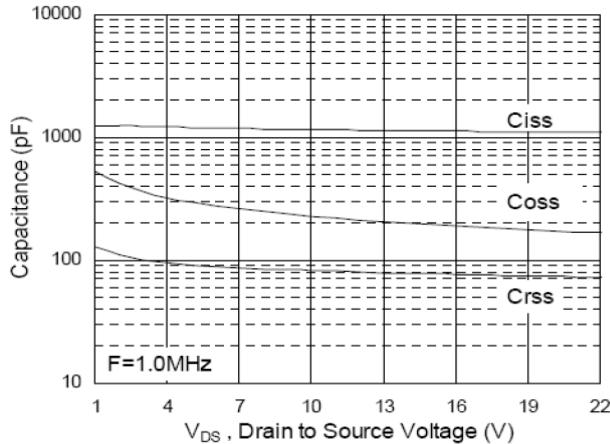


Fig.7 Capacitance

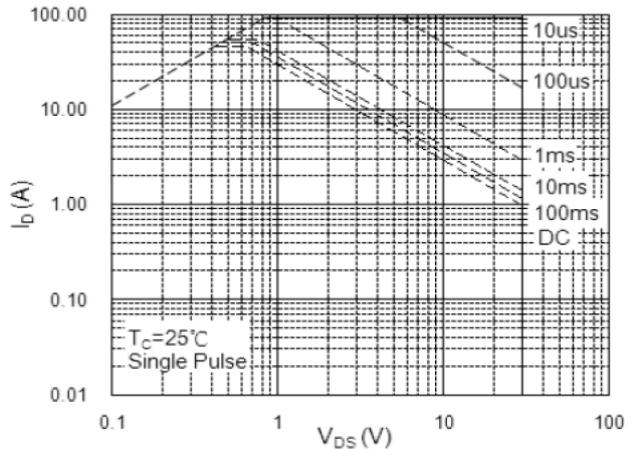


Fig.8 Safe Operating Area

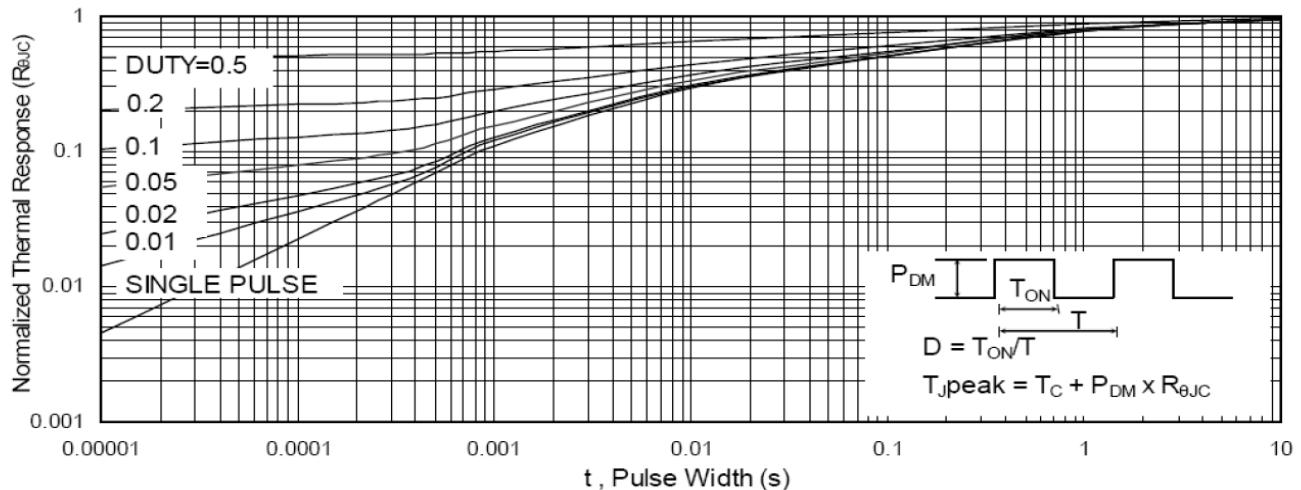


Fig.9 Normalized Maximum Transient Thermal Impedance

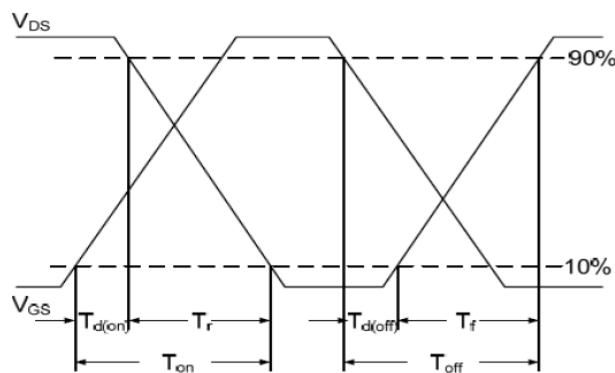


Fig.10 Switching Time Waveform

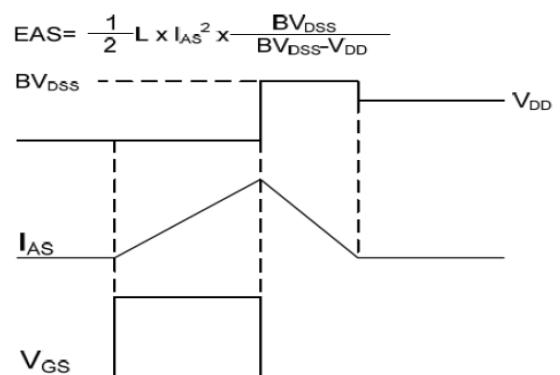


Fig.11 Unclamped Inductive Switching Wave